



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

# **Product Summary**

Device	V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub>	Ι <sub>D</sub> T <sub>A</sub> = +25°C
Q1	30V	3.4A	
QI	300	100mΩ @ V <sub>GS</sub> = 4.5V	2.7A
Q2	-30V	95mΩ @ V <sub>GS</sub> = -10V	-2.8A
Q2	-307	-2.3A	

#### Description

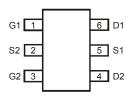
This new generation MOSFET has been designed to minimize the onstate resistance (R<sub>DS(on)</sub>) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

## Applications

- Backlighting
- **DC-DC Converters**
- Power management functions



Top View



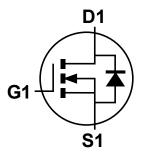
Top View

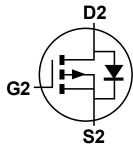
#### Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

#### Mechanical Data

- Case: TSOT26 •
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 @3)
- Weight: 0.013 grams (approximate)





Q1 N-Channel MOSFET

Q2 P-Channel MOSFET

#### Ordering Information (Note 4)

Part Number	Case	Packaging
DMG6602SVTX-7	TSOT26	3000 / Tape & Reel
DMG6602SVTX-13	TSOT26	10000 / Tape & Reel

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green"

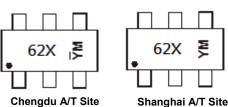
and Lead-free

Notes:

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

# **Marking Information**



62X = Product Type Marking Code YM = Date Code Marking for SAT (Shanghai Assembly/ Test site) YM = Date Code Marking for CAT (Chengdu Assembly/ Test site)

Y or  $\overline{Y}$  = Year (ex: A = 2013)

M = Month (ex: 9 = September

Chengdu A/T Site

Date Code Key												
Year	201	0	2011		2012	20	13	2014		2015	2	2016
Code	Х		Y		Z		4	В		С		D
Month	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



## Maximum Ratings – Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristi	Symbol	Value	Unit		
Drain-Source Voltage	V <sub>DSS</sub>	30	V		
Gate-Source Voltage			V <sub>GSS</sub>	±20	V
Continuous Drain Current (Note 5) $V_{GS}$ = 10V	Steady State	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	Ι <sub>D</sub>	3.4 2.7	А
Continuous Drain Current (Note 5) $V_{GS}$ = 4.5V	I <sub>D</sub>	2.7 2.2	А		
Maximum Continuous Body Diode Forward Curre	Is	1.5	А		
Pulsed Drain Current (Note 6)	I <sub>DM</sub>	13.0	A		

## Maximum Ratings – Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristi	Symbol	Value	Unit		
Drain-Source Voltage			V <sub>DSS</sub>	-30	V
Gate-Source Voltage			V <sub>GSS</sub>	±20	V
Continuous Drain Current (Note 5) $V_{GS}$ = -10V	Steady State	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	Ι <sub>D</sub>	-2.8 -2.4	А
Continuous Drain Current (Note 5) $V_{GS}$ = -4.5V	I <sub>D</sub>	-2.3 -2.1	А		
Maximum Continuous Body Diode Forward Curre	Is	-1.5	А		
Pulsed Drain Current (Note 6)	I <sub>D</sub>	-11.2	А		

#### **Thermal Characteristics**

Characteristic	Symbol	Value	Unit
Power Dissipation (Note5)	PD	1.0	W
Thermal Resistance, Junction to Ambient $@T_A = +25^{\circ}C$ (Note 5)	R <sub>θJA</sub>	124	°C/W
Operating and Storage Temperature Range	TJ, T <sub>STG</sub>	-55 to +150	°C

## Electrical Characteristics – Q1 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)	Cymber			шах	Unit	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	_	_	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA
Zero Gate Voltage Drain Current	IDSS	_	—	1.0	μA	V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)			•	•		· · · ·
Gate Threshold Voltage	V <sub>GS(th)</sub>	0.5	1.2	1.8	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
Static Drain-Source On-Resistance	Rds (ON)	_	35 50 100	60 100 200	mΩ	$V_{GS} = 10V, I_D = 3.1A$ $V_{GS} = 4.5V, I_D = 2A$ $V_{GS} = 3.3V, I_D = 1.5A$
Forward Transfer Admittance	Y <sub>fs</sub>	_	4	—	S	V <sub>DS</sub> = 5V, I <sub>D</sub> = 3.1A
Diode Forward Voltage	V <sub>SD</sub>	_	0.8	1	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 1A
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	Ciss	—	234	—		
Output Capacitance	Coss	—	42	—	pF	$V_{DS} = 15V, V_{GS} = 0V,$ f = 1 0MHz
Reverse Transfer Capacitance	Crss	—	40			1 - 1.00012
Gate Resistance	Rg	_	1.45	—	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$
Total Gate Charge (V <sub>GS</sub> = 4.5V)	Qg	—	3.6	—		V <sub>DS</sub> = 15V, V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 3A
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg	_	7.3	—	nC	
Gate-Source Charge	Q <sub>gs</sub>	—	0.9	—	nc	V <sub>DS</sub> = 15V, V <sub>GS</sub> = 10V, I <sub>D</sub> = 3A
Gate-Drain Charge	Q <sub>gd</sub>	_	1.6	—		
Turn-On Delay Time	t <sub>D(on)</sub>	_	3.6	—		
Turn-On Rise Time	tr	_	2.5	—		V <sub>GS</sub> = 10V, V <sub>DS</sub> = 15V,
Turn-Off Delay Time	t <sub>D(off)</sub>	_	16	—	ns	$R_G = 3\Omega, R_L = 1.7\Omega$
Turn-Off Fall Time	t <sub>f</sub>	_	6	—		

Notes: 5. Device mounted on FR-4 with minimum recommended pad layout, single sided.

6. Repetitive rating, pulse width limited by junction temperature.

7. Short duration pulse test used to minimize self-heating effect.

8. Guaranteed by design. Not subject to production testing.

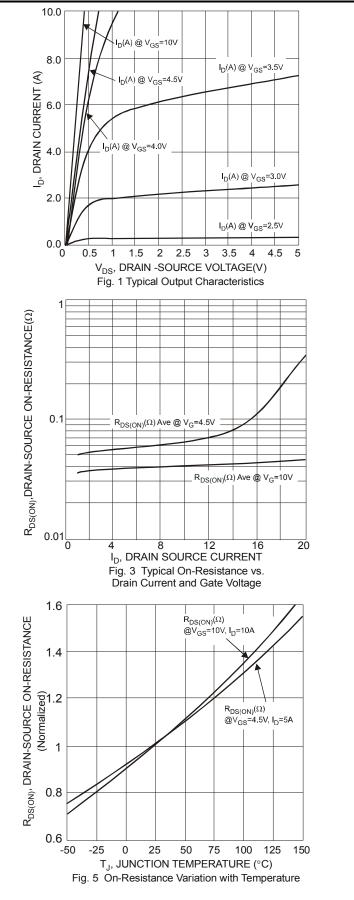


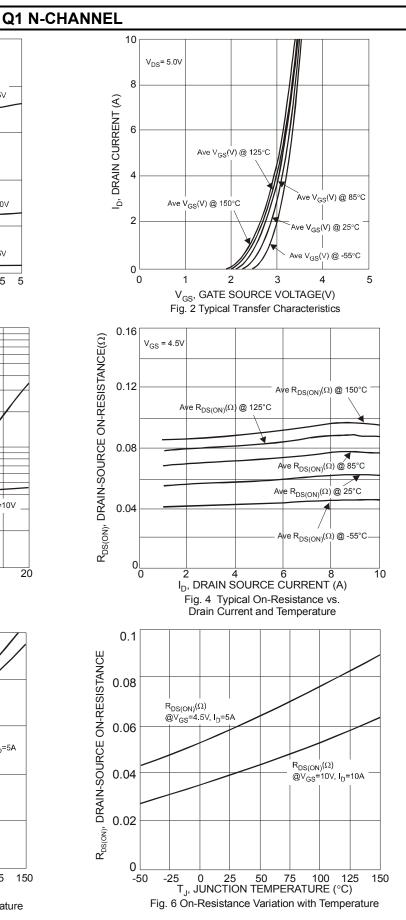
# Electrical Characteristics – Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

			_			
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 7)			<del>.</del>	<del>.</del>	i	+
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-30	—	—	V	$V_{GS} = 0V, I_D = -250\mu A$
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	—	-1.0	μA	$V_{DS}$ = -24V, $V_{GS}$ = 0V
Gate-Source Leakage	I <sub>GSS</sub>	_		±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 7)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	-0.5	-1.5	-2.2	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
			75	95		V <sub>GS</sub> = -10V, I <sub>D</sub> = -2.7A
Static Drain-Source On-Resistance	R <sub>DS (ON)</sub>	_	105	140	mΩ	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -2A
			140	200		V <sub>GS</sub> = -3.3V, I <sub>D</sub> = -1.5A
Forward Transfer Admittance	Y <sub>fs</sub>	_	6	_	S	V <sub>DS</sub> = -5V, I <sub>D</sub> = -2.7A
Diode Forward Voltage	V <sub>SD</sub>	_	-0.8	-1.0	V	$V_{GS} = 0V, I_{S} = -1A$
DYNAMIC CHARACTERISTICS (Note 8)						
Input Capacitance	C <sub>iss</sub>	_	410	-		
Output Capacitance	C <sub>oss</sub>	—	50		pF	V <sub>DS</sub> = -15V, V <sub>GS</sub> = 0V, f = 1.0MHz
Reverse Transfer Capacitance	C <sub>rss</sub>	_	45	—		
Gate Resistance	Rg	_	6.2	_	Ω	$V_{DS}$ = 0V, $V_{GS}$ = 0V, f = 1MHz
Total Gate Charge (V <sub>GS</sub> = -4.5V)	Qg	_	3.7	—		V <sub>DS</sub> = -15V, V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -3A
Total Gate Charge (V <sub>GS</sub> = -10V)	Qg		7.8	—	nC	
Gate-Source Charge	Q <sub>gs</sub>	—	1.1		IIC	V <sub>DS</sub> = -15V, V <sub>GS</sub> = -10V, I <sub>D</sub> = -3A
Gate-Drain Charge	Q <sub>gd</sub>	_	1.3	—		
Turn-On Delay Time	t <sub>D(on)</sub>		3.3	—		
Turn-On Rise Time	tr		3.0	—	ns	V <sub>GS</sub> = -10V, V <sub>DS</sub> = -15V,
Turn-Off Delay Time	t <sub>D(off)</sub>		14	—	115	$R_G = 6\Omega, R_L = 15\Omega$
Turn-Off Fall Time	t <sub>f</sub>	_	6.8	_		

Notes:7. Short duration pulse test used to minimize self-heating effect.8. Guaranteed by design. Not subject to production testing.



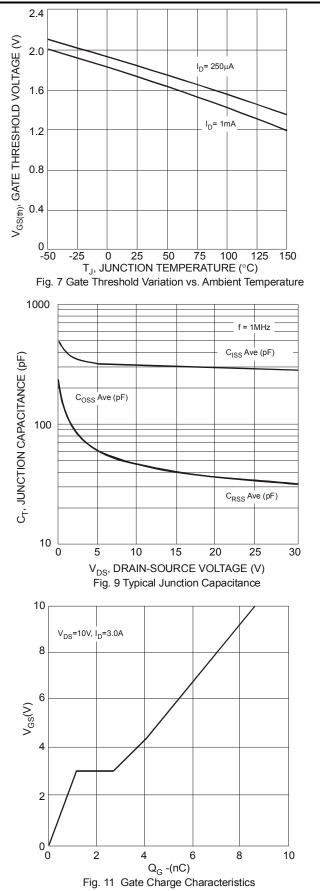


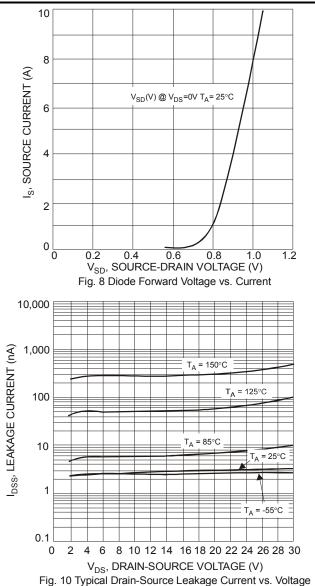


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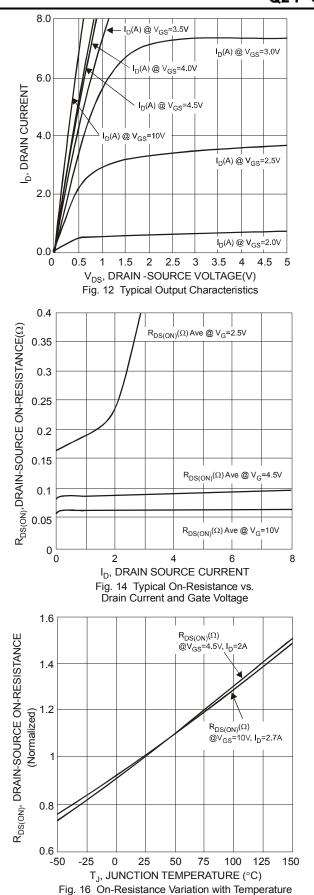












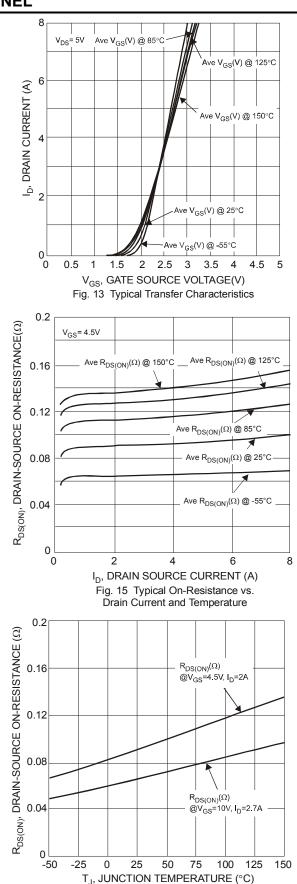


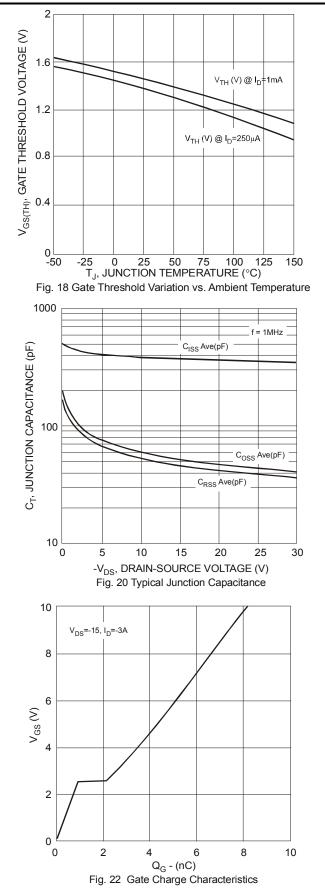
Fig. 17 On-Resistance Variation with Temperature

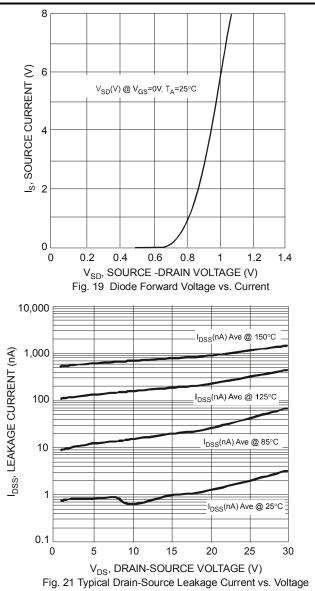
# Q2 P-CHANNEL

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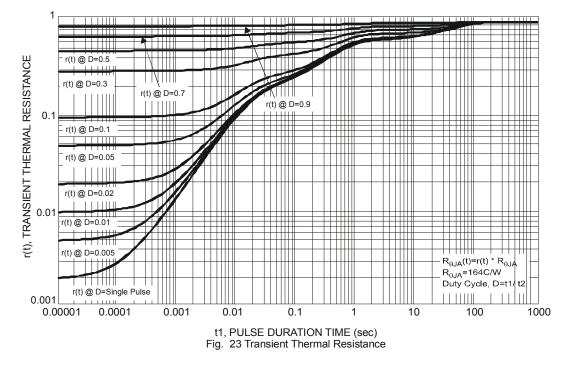
#### **Q2 P-CHANNEL**





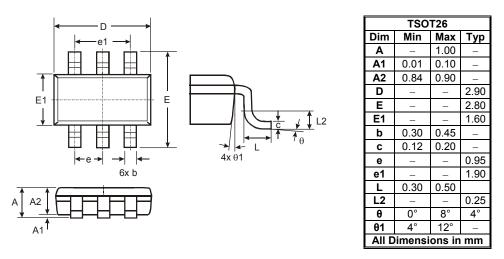
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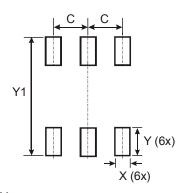
## **Package Outline Dimensions**

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



## Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
С	0.950
Х	0.700
Y	1.000
Y1	3.199

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  - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
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